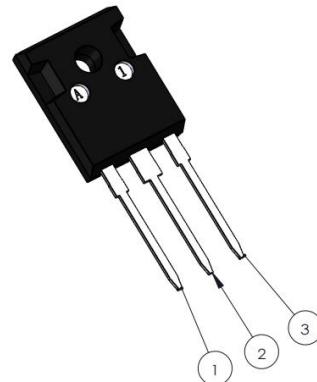


### **Gen2 Description**

Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

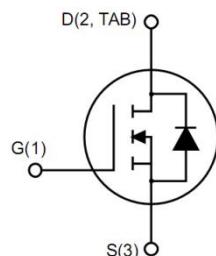
### **Features**

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free



### **Application**

- EV Charging
- DC/DC Converters
- Switch Mode Power Supplies
- UPS
- Solar PV inverters



### **Ordering Information**

Part Number	Marking	Package	Packaging
AMG60N650MT3	AMG60N650MT3	TO247-3	Tube

**Absolute Maximum Ratings(T<sub>c</sub>=25 °C)**

<b>Symbol</b>	<b>Parameter</b>	<b>Value</b>	<b>Unit</b>
V <sub>DS</sub>	Drain-Source Voltage	650	V
I <sub>D</sub>	Drain Current(continuous)at T <sub>c</sub> =25 °C	60	A
I <sub>D</sub>	Drain Current(continuous)at T <sub>c</sub> =100 °C	48	A
I <sub>DM</sub>	Drain Current (pulsed)	135	A
V <sub>GS</sub>	Gate-Source Voltage	-10/+22	V
P <sub>D</sub>	Power Dissipation T <sub>C</sub> = 25°C	395	W
T <sub>J</sub> , T <sub>tsg</sub>	Junction and Storage Temperature Range	-55 to +175	°C

**Electrical Characteristics(T<sub>J</sub> = 25 °C unless otherwise specified)**
**Typical Performance-Static**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
BV <sub>DS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> =250uA, V <sub>GS</sub> =0V	650			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V , T <sub>J</sub> =25°C		5	100	μ A
I <sub>GSS</sub>	Gate-body Leakage Current	V <sub>DS</sub> =0V ; V <sub>GS</sub> = -10 to 20V		10	250	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =10mA	2	3	4	V
V <sub>GSon</sub>	Recommended turn-on Voltage	Static		18		V
V <sub>GSoff</sub>	Recommended turn-off Voltage			-5		V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> =18V, I <sub>D</sub> =30A		38	49	mΩ
		V <sub>GS</sub> =18V, I <sub>D</sub> =30A T <sub>J</sub> =175°C		50		mΩ

**Typical Performance-Dynamic**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input Capacitance	$V_{DS}=600V, f=1MHz$ , $V_{AC}=25mV$		2612		pF
$C_{oss}$	Output Capacitance			212		pF
$C_{rss}$	Reverse Transfer Capacitance			10		pF
$g_{fs}$	Transconductance	$V_{DS}=20V, I_D=20A$		23		S
$E_{OSS}$	$C_{OSS}$ Stored Energy	$V_{DS}=600V, f=1MHz$		22		$\mu J$
$E_{ON}$	Turn-On Energy (Body Diode)	$V_{DS}=400V, V_{GS}=-5/20V$ , $I_D=30A, L=100\mu H$ $T_J=175^\circ C$		220		$\mu J$
$E_{OFF}$	Turn-Off Energy (Body Diode)			45		$\mu J$
$Q_g$	Total Gate Charge	$V_{DS}=400V, V_{GS}=-5V/20V$ , $I_D = 30A$		128		nC
$Q_{gs}$	Gate-source Charge			33		nC
$Q_{gd}$	Gate-Drain Charge			24		nC
$R_{G(int)}$	Internal Gate Resistance	$f=1MHz, V_{AC}=25mV$		4.1		$\Omega$
$t_{d(on)}$	Turn-on Delay Time	$V_{DS}=400V, V_{GS}=-5V/20V$ , $I_D = 30A, L=100 \mu H$ $R_{ext}=2.5\Omega$		12		ns
$t_r$	Rise Time			35		ns
$t_{d(off)}$	Turn-off Delay Time			22		ns
$t_f$	Fall Time			9		ns

**Typical Performance-Reverse Diode( $T_J = 25^\circ C$  unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{FSD}$	Forward Voltage	$V_{GS}=0V, I_F=15A, T_J=25^\circ C$		3.5	6	V
		$V_{GS}=0V, I_F=15A, T_J=175^\circ C$		3.0	6	V
$I_s$	Continuous Diode Forward Current	$V_{GS}=0V, T_C=25^\circ C$		30.5		A
$t_{rr}$	Reverse Recovery Time	$V_{GS}=-5 V, I_F=15 A$ , $V_R=400 V, T_J=175^\circ C$ $dI/dt=2400 A/\mu s$		36		nS
$Q_{rr}$	Reverse Recovery Charge			160		nC
$I_{rrm}$	Peak Reverse Recovery Current			10.5		A

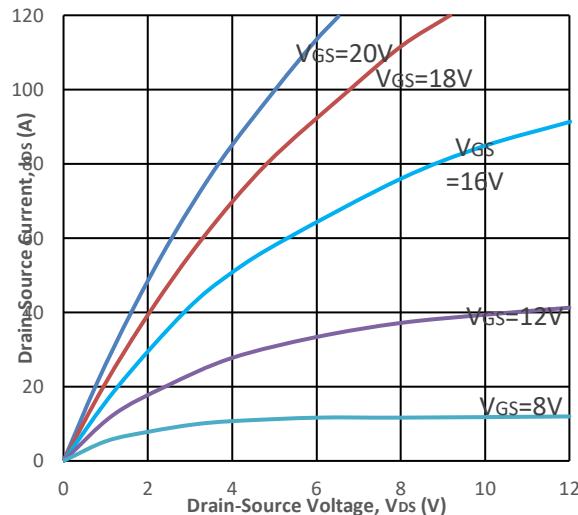
**Thermal Characteristics**

Symbol	Parameter	Value.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.38	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	40	$^\circ C/W$

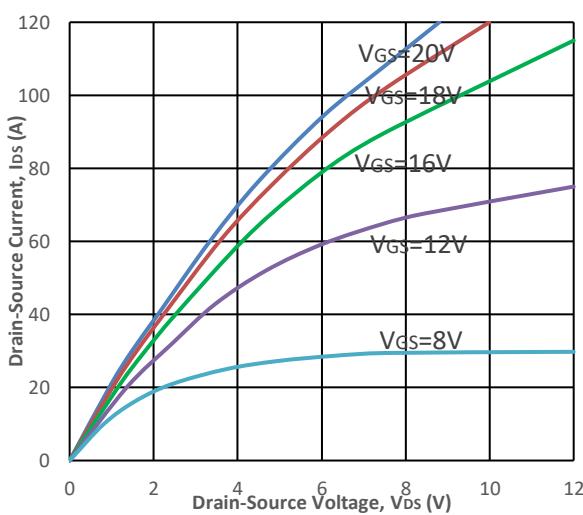
The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of  $T_J(max)=175^\circ C$

## Electrical Characteristics

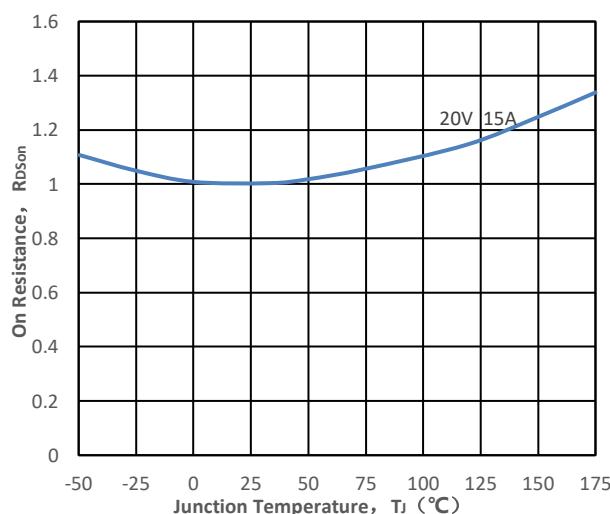
**Fig1. Output characteristics ( $T_J = 25^\circ C$ )**



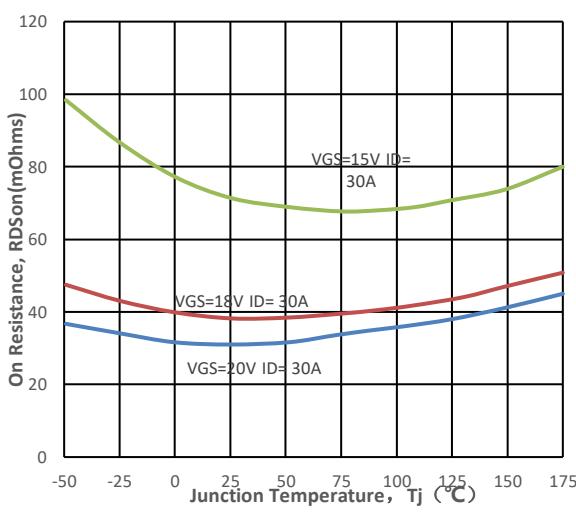
**Fig2. Output characteristics ( $T_J = 175^\circ C$ )**



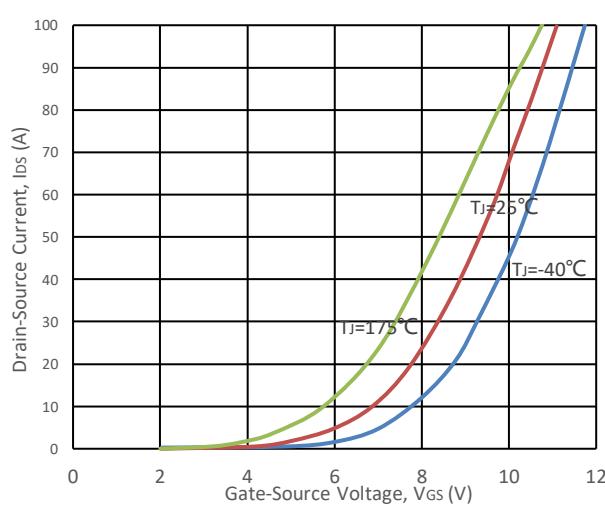
**Fig3. Normalized On-Resistance vs. Temperature**



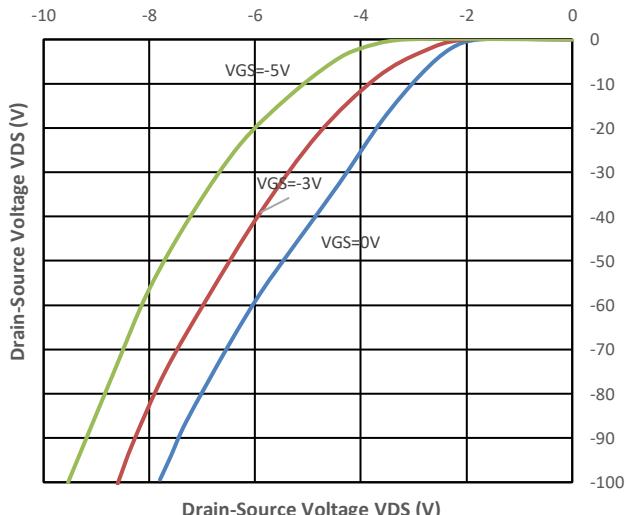
**Fig4. On-Resistance vs. Temperature**

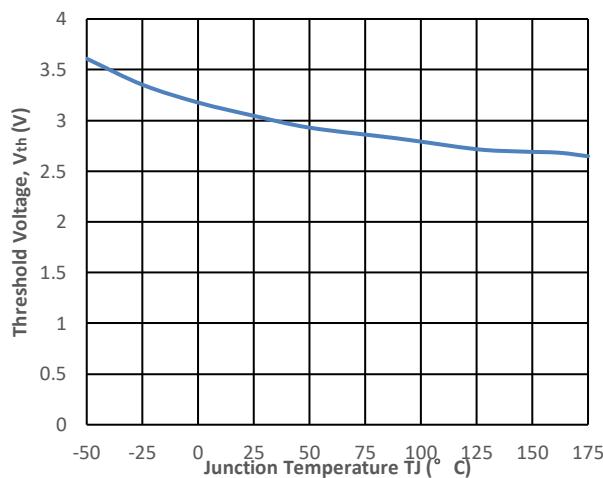
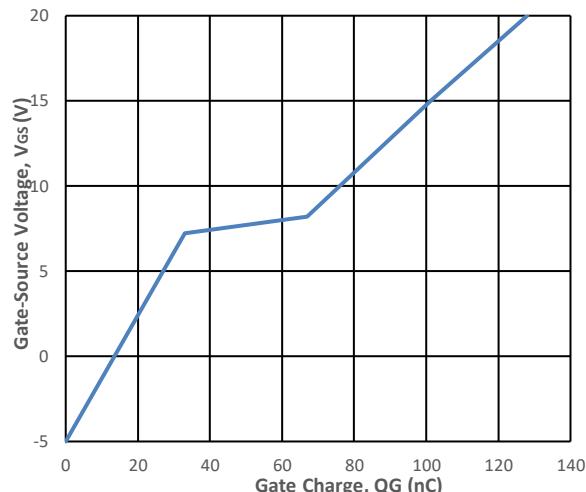
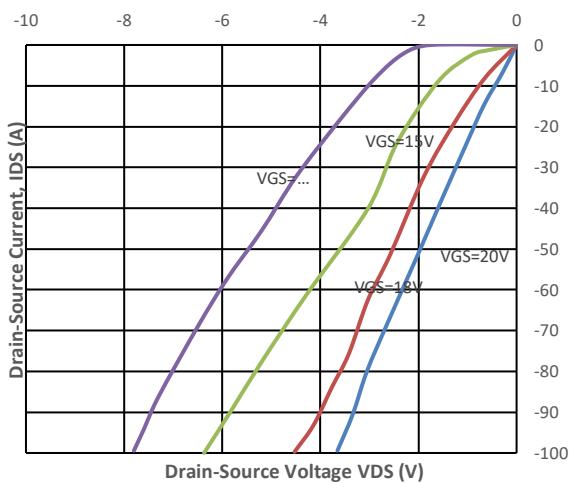
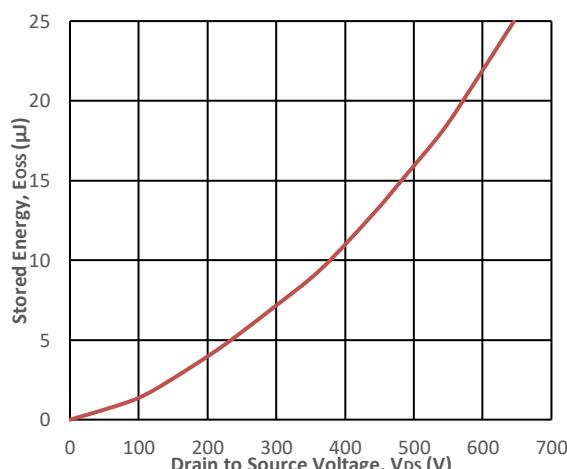
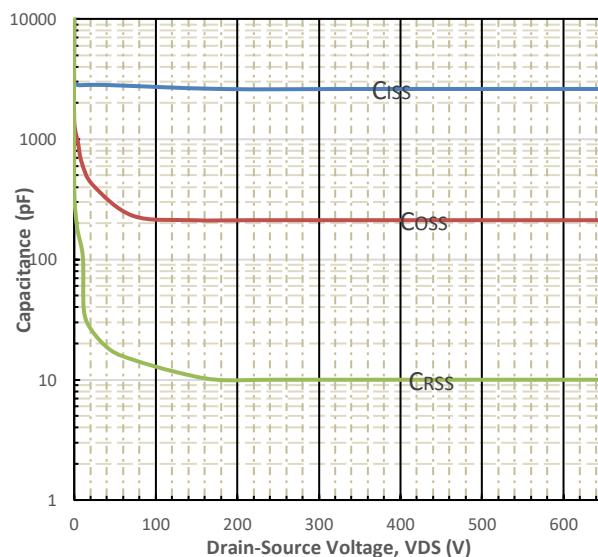
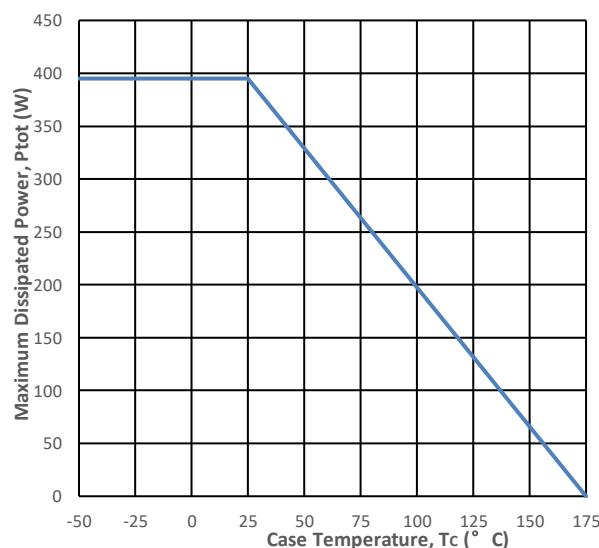


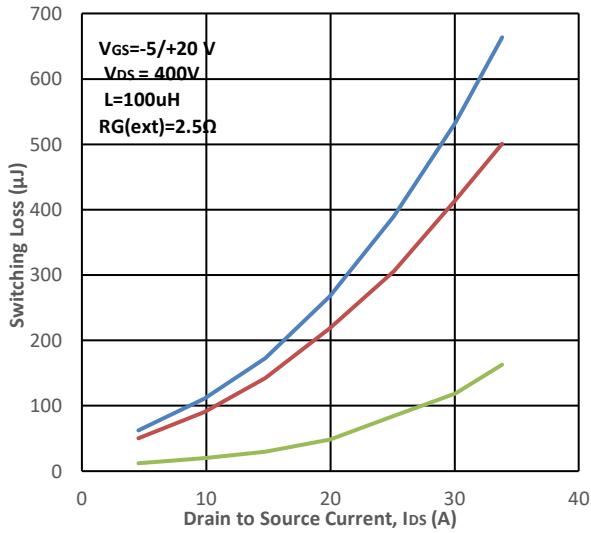
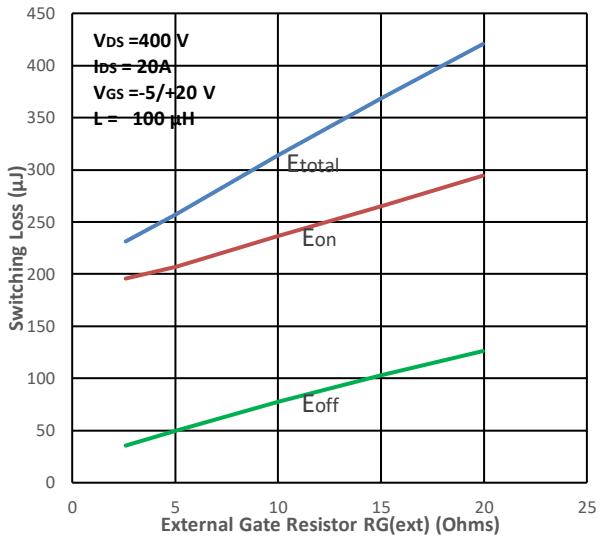
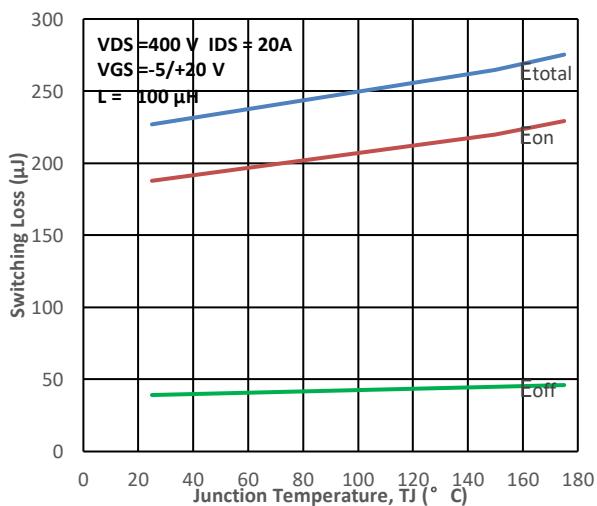
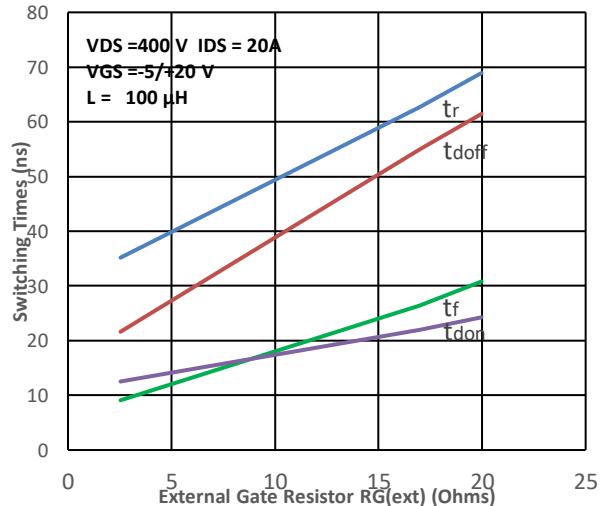
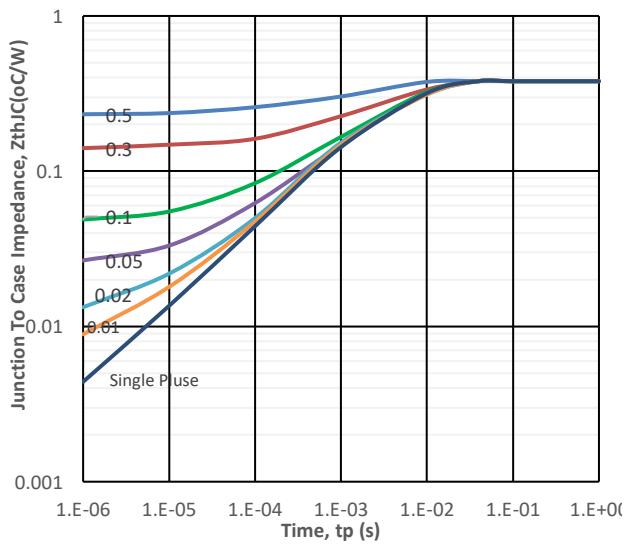
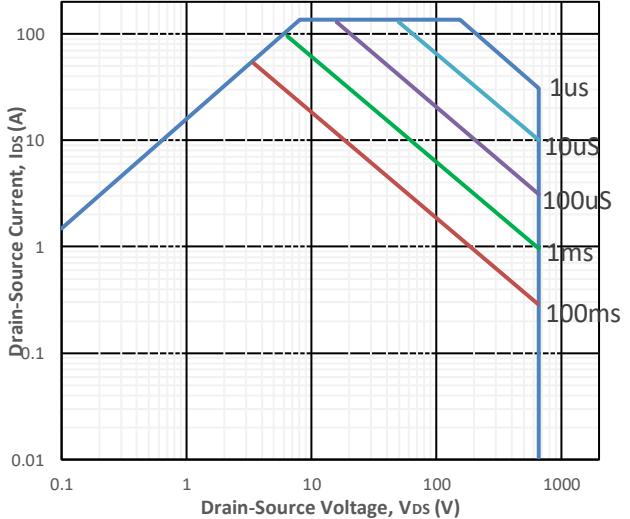
**Fig5. Transfer Characteristic**



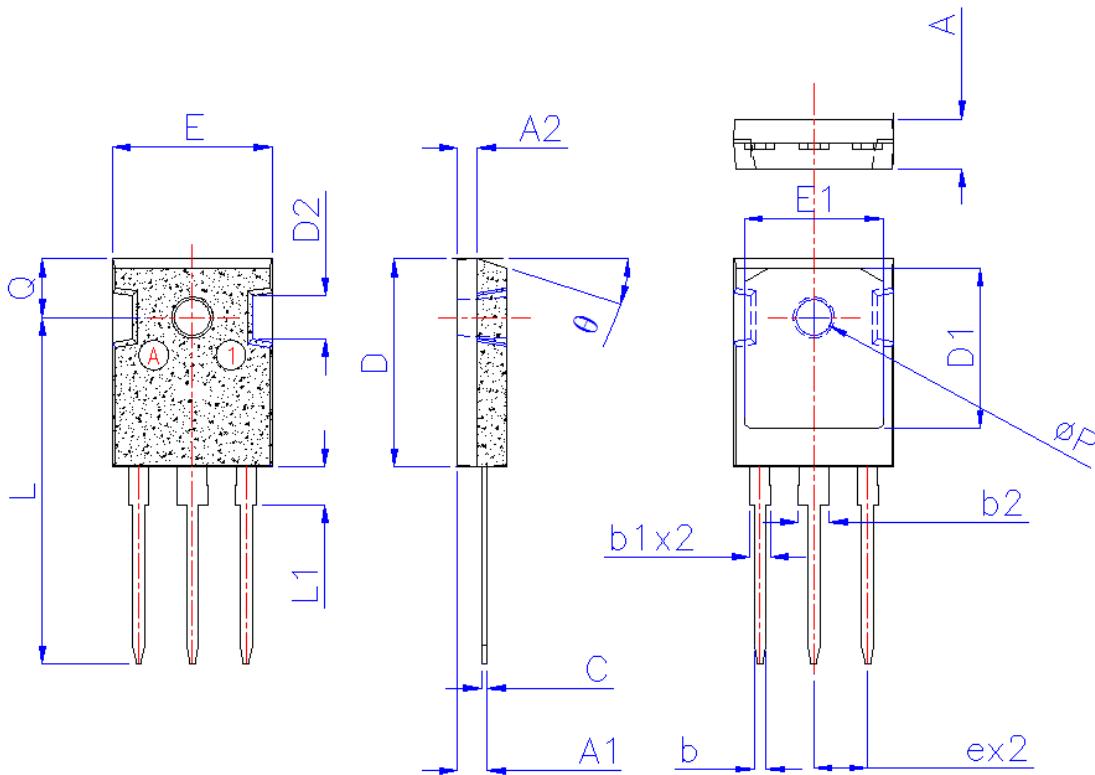
**Fig6. Body Diode Characteristic at  $25^\circ C$**



**Fig7.Threshold Voltage vs. Temperature**

**Fig8. Gate Charge Characteristics**

**Fig9. 3rd Quadrant Characteristic at 25 °C**

**Fig10. Output Capacitor Stored Energy**

**Fig11. Capacitances vs. Drain-Source**

**Fig12. Max Power Dissipation Derating Vs Tc**


**Fig13. Switching Energy vs. Drain Current**

**Fig14. Switching Energy vs. RG(ext)**

**Fig15. Switching Energy vs. Temperature**

**Fig16. Switching Times vs. RG(ext)**

**Fig17. Transient Thermal Impedance**

**Fig18. Safe Operating Area**


**Package Drawing:**



**Dimensions (UNIT: mm)**

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	TYPE	MAX	MIN	TYPE	MAX
A	4.80	5.00	5.20	0.189	0.197	0.205
A1	2.85	3.00	3.15	0.112	0.118	0.124
b	1.16	1.22	1.27	0.046	0.048	0.050
b1	2.03	2.06	2.10	0.080	0.081	0.083
b2	3.03	3.06	3.10	0.119	0.120	0.122
C	0.55	0.60	0.65	0.022	0.024	0.026
D	20.80	21.00	21.20	0.819	0.827	0.835
D1	15.94	16.24	16.54	0.628	0.639	0.651
D2	4.30 BSC			0.169 BSC		
e	5.44 BSC			0.214 BSC		
E	15.95	16.15	16.35	0.628	0.636	0.644
E1	13.82	14.02	14.26	0.544	0.552	0.561
L	34.65	35.05	35.45	1.364	1.380	1.396
L1	-	-	3.86	-	-	0.152
Q	5.85	5.95	6.05	0.230	0.234	0.238
øP	3.45	3.60	3.75	0.136	0.142	0.148
θ	17.5°			0.689°		